





### **Write-Back Policy**

When to transfer data to lower, more reliable level?

### Write-through

- most reliable
- effectively eliminates upper level from reliability hierarchy

#### **Delayed-write**

- e.g. write new data to memory, then transfer to disk after 15 seconds
- trade-off between reliability and overhead (e.g. performance)

## **Metrics for a Reliability Hierarchy**

### Mean time to data loss (MTTDL)

- limited by reliability of highest (least reliable) level
- doesn't distinguish between degrees of data loss

### Data loss rate

fraction of new data lost over time

$$\sum_{\text{all levels}} \frac{data \ loss_L}{MTTF_L}$$

# **Example Faults and Storage Levels**

Fault Category	Example MTTF	Storage Levels Affected by Fault				
		CPU/ memory	disk	RAID	on-site backup	remote backup
operating system	2 months	<ul> <li>✓</li> </ul>				
file system	5 years	~	<b>~</b>	~		
power	10 years (UPS)	~				
motherboard	5 years	~				
media	5 years		<b>/</b>			
catastrophe	50 years	~	<b>~</b>	<b>~</b>	~	



overall MTTDL = 0.15 years data loss rate = 10 hours/year



# **Example Faults and Storage Levels**

Fault	Example	Storage Levels Affected by Fault				
Category	MTTF	CPU/memory	CPU/memory with Rio	disk		
operating system	2 months	<ul> <li>✓</li> </ul>				
file system	5 years	<ul> <li>✓</li> </ul>	<ul> <li>✓</li> </ul>	<b>v</b>		
power	10 years (UPS)	<ul> <li>✓</li> </ul>	<ul> <li>✓</li> </ul>			
motherboard	5 years	<ul> <li>✓</li> </ul>	<ul> <li>✓</li> </ul>			
media	5 years			<b>v</b>		
catastrophe	50 years	<ul> <li>✓</li> </ul>	<ul> <li>✓</li> </ul>	<b>v</b>		



overall MTTDL = 0.15 years  $\rightarrow$  1.4 years data loss rate = 10 hours/year

## **Conclusions**

### **Two views of hierarchies**

trade-off between cost and performance

 trade-off between reliability and performance/ cost/power/etc.

# Rio fills in the "reliability gap" between memory and disk

 hypothesis: can use Rio to store new types of data that would like higher reliability than memory but can't afford overhead of disk



http://www.eecs.umich.edu/Rio